Features

- Ideal for Use in PC100 Registered DIMM
- 0.5mm CMOS Technology
- 2.3 ~ 3.6 V_{cc} Operation
- Output Port Has 26-ΩSeries Damping Resistor, No External Resistors are Required
- Package Options Include Plastic Thin Shrink Small-Outline Packages, Shrink Small-Outline Packages, Thin Very Small Outline Packages (TSSOP 56 Pins, SSOP 56 Pins, TVSOP 56 Pins)

Pin Configuration

		(1)	
NC	₫	1	\bigcirc	56	
NC		2		55	□ мс
Y1		3		54	□ A1
GND		4		53	GND
Y2		5		52	□ A2
Y3		6		51	_ A3
Vcc		7		50	
Y4		8		49	□ A4
Y5		9		48	 A5
Y6		10		47	A 6
GND		11		46	
Y7		12		45	🗆 A7
Y8		13		44	A8
Y9		14		43	_ A9
Y10		15		42	A10
Y11		16		41	A11
Y12		17		40	A12
GND		18		39	GND
Y13		19		38	A13
Y14		20		37	A14
Y15		21		36	A15
Vcc		22		35	
Y16		23		34	A16
Y17		24		33	A17
GND		25		32	
Y18		26		31	A18
ŌĒ		27		30	
LE		28		29	
	_				-

NC- No ineternal connection

General Description

The HG74ALVC162835C is an 18-bit universal bus driver designed for 2.3V to 3.6 V $V_{\rm CC}$ Operation.

The Output Enable(\overline{OE}) controls data flow from A to Y. The device operates in transparent mode when the latch-enable(LE) input is high. When LE is low, the A data is latched if the clock input is held at a high or low logic level. If LE is low, the A data is stored in the latch/flip-flop on the low-to-high transition of CLK.

When \overline{OE} is high, the Outputs are in the high impedance state. \overline{OE} should be tied to V_{CC} through a pull up resistor to ensure the high impedance state during power up or power down.

The equivalent $26 \cdot \Omega$ series resistors are included in the output to reduce overshoot and undershoot.

The HG74ALVC162835C is characterized for operation from -40°C to 85° C.

Function Table

	INPU	OUTPUT		
ŌĒ	LE	CLK	Α	Y
Н	Х	Х	Х	Z
L	Н	Х	L	L
Г	Н	Х	Н	Н
L	L	\uparrow	L	L
L	L	\uparrow	Н	Н
1		L or H	X	Y.†

Output level before the indicated steady-state input conditions were established, provided that CLK is high before LE goes low.



Logic Diagram (positive logic)



TO 17 Other Channels

Absolute Maximum Ratings Over Operating Free-air Temperature Ranget

Symbols	Parameter	Value	Conditions
V _{cc}	Supply Voltage Range	-0.5 V to 4.6 V	
V	Input Voltage Range (see note 1)	-0.5 V to V _{cc} + 0.5 V	
Vo	Output Voltage Range (see notes 1 and 2)	-0.5 V to V _{cc} + 0.5 V	
I _{IK}	Input Clamp Current	-50 mA	V ₁ < 0
Ι _{οκ}	Output Clamp Current	±50 mA	$V_{\rm O}$ <0 or $V_{\rm O}$ > $V_{\rm CC}$
Ι _ο	Continuous Output Current	±50 mA	V_{O} =0 to V_{CC}
I _{cc}	Continuous Current through each V _{cc}	+100 mA	
I _{GND}	Continuous Current through each GND	-100 mA	
T _{stg}	Storage Temperature Range	- 65°C to 150°C	

†Stresses beyond those listed under "absolute maximum rating" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating condition" is not implied. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability.

Note 1) The input and output voltage ratings may be exceeded if the input and output clamp current are observed. Note 2) This value is limited to 4.6 V maximum.



Recommended Operating Conditions (see Note 3)

Cumhala	Deremeter	Va	lue			
Symbols	Parameter	MIN	MAX	Units	Conditions	
V _{cc}	Supply Voltage	2.3	3.6	V		
V	High lovel input Veltage	1.7		V	V _{cc} =2.3V to 2.7V	
v _{IH}	Tilgit level liput voltage	2		V	V _{CC} =2.7V to 3.6V	
V	Low lovel input Veltage		0.7	V	V _{CC} =2.3V to 2.7V	
VIL	Low-level input voltage		0.8	V	V _{CC} =2.7V to 3.6V	
VI	Input Voltage	0	V _{cc}	V		
Vo	Output Voltage	0	V _{cc}	V		
			-6	mA	V _{CC} =2.3V	
I _{OH}	High-level output current		-8	mA	V _{CC} =2.7V	
			-12	mA	V _{CC} =3V	
			6	mA	V _{CC} =2.3V	
I _{OL}	Low-level output current		8	mA	V _{cc} =2.7V	
			12	mA	$V_{cc} = 3V$	
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	ns/V		
T _A	Operating free-air temperature	-40	85	°C		

Note 3) All unused inputs of the device must be held at $V_{\rm cc}$ or GND to ensure proper device operation.

Electrical Characteristics Over Recommended Operating Free-air Temperature Range

					Value			
Para	ameter	Test Co	nditions	Min	Typ t	Мах	Units	V _{cc}
		I _{OH} = -100μA		V _{cc} -0.2				2.3V to 3.6V
		I _{OH} = - 4mA	V _{IH} =1.7V	1.9				2.3V
V		I _{он} = - 6mA	V _{IH} =1.7V	1.7			V	2.3V
۷O	Н		$V_{IH} = 2V$	2.4			v	3V
		I _{он} = - 8mA	$V_{IH} = 2V$	2				2.7V
		I _{он} = -12 mА	$V_{IH} = 2V$	2				3V
		I _{OL} = 100μA				0.2		2.3V to 3.6V
		$I_{OL} = 4mA$	$V_{IL} = 0.7V$			0.4		2.3V
V		$I_{OL} = 6mA$	$V_{IL} = 0.7V$			0.55	V	2.3V
¥0	L		$V_{IL} = 0.8V$			0.55	v	3V
		I _{OL} =8mA	$V_{IL} = 0.8V$			0.6		2.7V
		I _{OL} =12mA	$V_{IL} = 0.8V$			0.8		3V
۱ _L		$V_{I} = V_{CC}$ or GND				±5		3.6V
I _{oz}	Ζ	$V_0 = V_{CC}$ or GND				±10		3.6V
		$V_1 = V_{CC}$ or GND				40	ıιΔ	2.6\/
I _{CI}	C	$I_0 = 0$				40	μι	5.0 V
Δl _{cc}		One input at V _{cc}	_c - 0.6V,			750		3V to $3.6V$
		Other inputs at \	√ _{cc} or GND			100		01 10 0.01
Control Inputs C ₁ Data Inputs					3.5			
		$V_1 = V_{CC}$ or GND			_		ρF	3.3V
					5			
C _o	Outputs	$V_0 = V_{CC}$ or GND)		7		ρF	3.3V

t All typical Values are at V_{CC} =3.3V, T_A = 25^{\circ}C.



18-BIT UNIVERSAL BUS DRIVER WITH 3-STATE OUTPUTS

Timing Requirements Over Recommended Operating Free-air Temperature Range(see figure1~10)

Symbol	Parameter	Conditio	Condition		V±0.2V	V _{cc}	=2.7V	V _{cc} =3.	3V±0.3V	Unit
-,				Min	Max	Min	Max	Min	Max	
f_{clock}	Clock frequency				150		150		150	MHz
+	Pulse	LE high		3.3		3.3		3.3		ns
ι _W	Duration	CLK high or low		3.3		3.3		3.3		ns
		Data before	CLK↑	0.9		0.9		0.7		ns
t _{su}	Setup time	Data bafara LE	CLK high	1.9		1.6		1.5		ns
		CLK low	1.3		1.1		1		ns	
		Data after 0	CLK↑	1.0		1.0		1.1		ns
t _h	Hold time	Data after $LE\downarrow$	CLK high or low	1.4		1.7		1.4		ns

Switching Characteristics Over Recommended Operating Free-air Temperature Range

Parameter	Input	Output	V _{cc} =2.5	V± 0.2V	V _{cc} =	:2.7V	V _{cc} =3.3	3V±0.3V	Unit
Farameter	(From)	(То)	Min	Max	Min	Max	Min	Max	Onit
f _{max}			150		150		150		MHz
	A		1	5		5	1	4.2	ns
t _{pd}	LE	Y	1.3	5.9		5.8	1.3	5.1	ns
	CLK		1.4	6.3		6.1	1.4	5.4	ns
t _{en}	I E	Y	1.4	6.3		6.5	1.1	5.5	ns
t _{dis}	ŌE	Y	1	4.9		4.9	1.3	4.5	ns

Switching Characteristics From 0°C to 65°C, CL=50 ρF

Parameter	Parameter Input		V _{cc} =3.3	Unit	
	(From)	(То)	Min	Max	Onit
t _{pd}	CLK	Y	1.9	5	ns



Parameter Measurement (V_{cc}=2.5V±0.2V)



Test	S1
t _{pd}	Open
t _{PLZ} / t _{PZL}	$2 \times V_{cc}$
t _{PHZ} /t _{PZH}	GND

Note) C_L includes probe and jig capacitance

Voltage Waveforms



Figure 2. Set up and Hold Times



Figure 3. Pulse Duration



Figure 4. Propagation Delay times







Note 1) Waveform1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform2 is for an output with internal conditions such that the output is high except when disabled by the output control Note 2) All input pulses are supplied by generators having the following characteristics:

 $\label{eq:PRR} \mathsf{PRR} \subseteq 10 Mhz, \, Z_o = 50 \Omega \ , \, t_r \subseteq 2ns, \, t_f \ \ \subseteq 2ns.$

Note 3) The output are measured one at a time with one transition per measurement.

Note 4) t_{PLZ} and t_{PHZ} $\;$ are the same as $t_{\mathsf{dis}}.$

Note 5) t_{PZL} and t_{PZH} are the same as t_{en} . Note 6) t_{PLH} and t_{PHL} are the same as t_{pd} .



Parameter Measurement (Vcc=2.7V and 3.3V \pm 0.3V)



Test	S1
t _{pd}	Open
t _{PLZ} / t _{PZL}	6V
t _{PHZ} /t _{PZH}	GND

Note) C_{L} includes probe and jig capacitance

Voltage Waveforms



Figure 7. Set up and Hold Times







Figure 9. Propagation Delay times

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Figure 10. Enable and Disable Times

Note 1) Waveform1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform2 is for an output with internal conditions such that the output is high except when disabled by the output control. Note 2) All input pulses are supplied by generators having the following characteristics :

 $\label{eq:pressure} \begin{array}{l} {\sf PRR} \subseteq 10 {\sf MHz}, {\sf Z}_{\sf o} = 50 \Omega, \quad t_{\sf r} \subseteq 2.5 {\sf ns}, \quad t_{\sf f} \quad \subseteq 2.5 {\sf ns}. \end{array}$ Note 3) The output are measured one at a time with one transition per measurement.

Note 4) t_{PLZ} and t_{PHZ} are the same as t_{dis} .

Note 5) t_{PZL} and t_{PZH} ~ are the same as t_{en} .

Note 6) t_{PLH} and t_{PHL} are the same as t_{pd} .

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